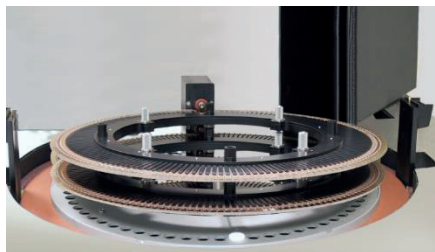




W-2200 LOW FREQUENCY CRYSTAL DISC PALLET TEMPERATURE TEST SYSTEM

- Automated, software based quartz crystal temperature test system for low frequency crystals
- Up to 2 disc pallets can be stacked
- Leaded and SMD discs available
- Custom sizes available
- Measures over 75 different parameters



- Parameter and curve fit characteristics are checked against easy to define QC limits
- Crystals of different frequencies can be tested in a single temperature run
- All data is published in a *Microsoft Access*™ data base
- Data can be exported to *Microsoft Excel*™ for custom data analysis
- Printouts are generated using *Crystal Reports*™
- Dual chamber configuration available

SPECIFICATIONS

**1000K Ohm Test Head
Frequency Range:**

10 KHz to 300 KHz

Frequency Correlation:

± 1 ppm* at series (typical)

Crystal Power:

1 uW into 25,000 Ohms Max

Temperature Stability:

± 0.1° C

* Proprietary measurement and calibration algorithms provide correlation to industry standard crystal measurement equipment.

The Roditi International Corporation Ltd

180 King's Cross Road, London WC1X 9DE, United Kingdom

Tel: +44 20 7819 8080 Fax: +44 20 7730 4131 Email: saunders@roditi.com Web: <https://roditi.com>

